

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/807,227	PARK ET AL.	÷
Examiner	Art Unit	
John m. Cooney	1711	

SEARCHED						
Class	Subclass	Date	Examiner			
521	102,109.1,121 125,128,130 140,142,143 146,144,150 182,183,186					
521	182,183,186 184	\ \ \				
424	426					
524	27,35,47					
525	82,115,289,495 165,166,186 242,298,312,418	7/07	100			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor	7/07	m	